Electronic Supplementary Information for

## An efficient organic solvent-free solution-processing strategy for high- mobility metal chalcogenide film growth

Jie Zhao,<sup>a</sup> Il Jeon,<sup>b</sup> Qinghua Yi,<sup>a</sup> Menka Jain,<sup>c</sup> Mark H. Rummeli,<sup>a</sup> Pingyuan Song,<sup>a</sup> Guifu Zou,\*<sup>a</sup> and Yutaka Matsuo\*<sup>b</sup>

<sup>a</sup>College of Physics, Optoelectronics and Energy & Collaborative Innovation Center of Suzhou Nano Science and Technology, Soochow University, Suzhou 215006, China.

<sup>b</sup>Department of Chemistry, School of Science, The University of Tokyo, 7-3-1 Hongo, Bunkyo-ku, Tokyo 113- 0033, Japan

<sup>c</sup>Institute of Materials Science & Department of Physics, University of Connecticut, Storrs, CT 06269-3046, United States of America

\*Corresponding author

Email: zouguifu@suda.edu.cn, or matsuo@photon.t.u-tokyo.ac.jp



**Fig. S1** Chemical structures of compounds produced by different valence metal chlorides with [Bmim][Cl].



Fig. S2 The effect of temperature on the viscosity of [Bmim][Cl] and CZT based ILPS.



**Fig. S3** TGA curves of various ILPSs for single (a-c), binary (d) and ternary (e-f) metal chlorides, respectively.

Thermal gravimetric analysis (TGA) data are plotted in Fig. S3 for various ILPS containing a variety of metal salts with different concentrations. As shown in Fig. S3a, most of single metal based ILPS exhibit substantial weight loss below temperatures of 260 °C, which corresponds to the thermal decomposition of [Bmim][Cl].<sup>[S1]</sup> Another weight loss feature is observed at temperatures just above 300 °C, which we attribute to [Bmim]<sub>y-nx</sub>[M<sub>x</sub>Cl<sub>y</sub>]. As shown in Fig. S3b-S3e, different valence states of metal ions and interacting modes with [Bmim][Cl] lead to ILPSs which exhibit a wide range of degradation temperatures from 260 to 470 °C. For instance, Zn, In and Ga based ILPSs show relatively higher decomposition temperatures than the other metal based ILPSs. Fig. S3b-S3c presents the relationship between the ion ( $Cu^{2+}$  and  $Zn^{2+}$ ) concentration of the ILPSs and their thermal decomposition. The data does not show obvious change at the onset decomposing temperature. However, for Zn based ILPSs, the ILPSs with a higher metal ion concentration have a higher decomposition temperature. These results highlight the potential for the rational design of the degradation temperature of such ILPSs for target metal chalcogenide films. Binary and ternary metal ion based ILPSs (Fig. S3d-S3f) have similar thermal degradation temperatures ranging from 250 to 470 °C. For example, Fig. S3f shows the TGA profiles for Cu ion concentrations from 0.36 to 2 M in Cu-Zn-Sn based ILPSs. One easily sees how the Cu ion concentration significantly influences the pyrolysis of ternary Cu-Zn-Sn based ILPS.



**Fig. S4** XRD patterns and Raman spectra for the optimum synthesis of metal chalcogenide films (e.g. CZTS) under different annealing temperature. Distinct structure peaks indicate that annealing temperature at 500 oC is more suitable for the high-quality preparation of metal chalcogenide films



Fig. S5 SEM cross-sectional image of CZTS film prepared after three spin-coatings.



**Fig. S6** XRD patterns of selected metal chalcogenide films including SnO<sub>2</sub>, Sn-doped In<sub>2</sub>O<sub>3</sub> (ITO), NiFe<sub>2</sub>O<sub>4</sub>, CdS, SnS<sub>2</sub> and SnSe<sub>2</sub>.



Fig. S7 Raman spectra of selected metal chalcogenide films (SnO<sub>2</sub>, NiFe<sub>2</sub>O<sub>4</sub>, SnS<sub>2</sub> and SnSe<sub>2</sub>).



Fig. S8 SEM top view images of NiO and NiFeO<sub>4</sub> films.

SnS <sub>2</sub>		CZTSe	
	Ļ		
-+37	220 nm	and the second	850 nm
$\left( \left( \right) \right)$	Substrate		
1115	500 nm		Substrate 500 nm

Fig. S9 SEM cross-sectional images of representative  $SnS_2$  and CZTSe films.

## References

(S1) N. Meine, F. Benedito and Rinaldi, R. Thermal stability of ionic liquids assessed by potentiometric titration. *Green Chem.* 2010, **12**, 1711-1714.